


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586108	<b>Applicant(s)/Patent Under Reexamination</b>  GAUDREAU, JEAN-ETIENNE
	<b>Examiner</b>  CHRIS H CHU	<b>Art Unit</b>  2874

SEARCHED			
Class	Subclass	Date	Examiner
385	5, 15	11/20/09	/CC/

SEARCH NOTES		
Search Notes	Date	Examiner
consulted with primary examiner Michelle Connelly-Cushwa	12/12/08	/CC/
updated searches	11/20/09	/CC/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
USPTO EAST: USPAT AND USPG-PUB (see attached text)		11/20/09	/CC/

/Chris Chu/	
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